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thin Solid films

Contents

Synthesis and Characterization

Room temperature reduction of MERIE-like plasma-induced interface states
E. Atanassova 1

Characterization of IrO_2 thin films by Raman spectroscopy
P.C. Liao, C.S. Chen, W.S. Ho, Y.S. Huang and K.K. Tiong 7

Ellipsometric characterization of an AISI 304 stainless steel protective coating
J.J. Fuentes-Gallego, E. Blanco and L. Esquivias 12

Electrical and structural characteristics of chromium thin films deposited on glass and alumina substrates
A.K. Kulkarni and L.C. Chang 17

Morphology and microstructure of polypyrrole formed by electrochemical polymerization
J. Shan, C. Yuan and H. Zhang 23

In situ reflection high energy electron bombardment analysis of biaxially oriented yttria-stabilized zirconia thin film growth on amorphous substrates
V. Betz, B. Holzapfel and L. Schultz 28

Low temperature zirconia thin film synthesis by a chemical vapour deposition process involving $ZrCl_4$ and O_2–H_2–Ar microwave post-discharges. Comparison with a conventional CVD hydrolysis process
J. Gavillet, T. Belmonte, D. Hertz and H. Michel 35

Analysis of thin film stress measurement techniques
S.G. Malhotra, Z.U. Rek, S.M. Yalisove and J.C. Bilello 45

Depth-sensitive strain analysis of a W–Ta–W trilayer
S.G. Malhotra, Z.U. Rek, S.M. Yalisove and J.C. Bilello 55

Monitoring the deposition of Cu thin film using the double exposure holographic interferometry technique
M.B. Dongre, V.J. Fulari and H.R. Kulkarni 62

Deposition of cubic boron nitride layers — characterisation of substrate–layer interface
K.-L. Barth, W. Sigle, D. Stöckle, J. Ulmer and A. Lunk 65

Synthesis of tungsten carbide thin films by reactive pulsed laser deposition
N. Chitica, E. Gyorgy, A. Lita, G. Marin, I.N. Mihailescu, D. Pantelica, M. Petrascu, A. Hatziapostolou, C. Grivas, N. Broll, A. Cornet, C. Mirica and A. Andrei 71

Enhanced diamond nucleation on pretreated silicon substrates
M.-R. Shen, H. Wang, Z.-Y. Ning, C. Ye, Z.-Q. Gan and Z.-X. Ren 77

Oxygen sensing properties of V_2O_5 cladded optical glass waveguide
Z.A. Ansari, R.N. Karekar and R.C. Aiyer 82

In situ TEM observation of metastable phase formed by solid state interdiffusion in a Co–Cu system
P. Wu, E.Y. Jiang, Y.G. Liu and C.D. Wang 90

Photoelectrolytic micelle disruption method for preparation of free patterns of pigment images
Y. Harima, K. Matsumoto, Y.-D. Wang and K. Yamashita 95

TEM characterization of plasma-sprayed thermal barrier coatings and ceramic–metal interfaces after hot isostatic pressing
H.C. Chen, J. Heberlein and E. Pfender 105

Structural and optical characterization of polycrystalline $CuInSe_2$
J.H. Schön, V. Alberts and E. Bucher 115

Photoconductivity — a novel method of evaluation of thin semiconducting film thickness
B. Pohoryles and A. Morawski 122

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Raman studies of diamond film growth on fuse-silica substrates by a multi-step process
G.L. Lin, J.T. Lue, C.L. Chen and I.N. Lin 126

Qualitative characterization of variation in elastic properties of solid solutions by acoustic microscopy
B. Cros, H. Nounah and J. Attal 134

Diffusion barrier properties of TaC between Si and Cu
J. Imahori, T. Oku and M. Murakami 142

Optical properties of nickel thin films deposited by electroless plating
E. Dumont, B. Dugnoille, J.P. Petitjean and M. Barigand 149

Dependence of the properties of $(Sr_xTi_{1-x})O_3$ thin films deposited by plasma-enhanced metal–organic chemical vapor deposition on electron cyclotron resonance plasma
J.S. Lee, H.W. Song, B.-H. Jun, D.H. Kwack, B.G. Yu, Z.-T. Jiang and K. No 154

Spontaneous aggregation of octaalkoxyphthalocyanine metal complexes at an air–water interface
Y. Matsuzawa, T. Seki and K. Ichimura 162

Interaction of flurbiprofen sodium with cornea model monolayers at the air–water interface
M.L. García, M.A. Egea, J. Valero, O. Valls and M.A. Alsina 169

Surfaces, Interfaces and Colloidal Behaviour

Electropolymerization of pyrrole and 4-(3-Pyrrolyl)butane-sulfonate on Pt substrate: An in situ EQCM study
B.J. Hwang, D.T. Shieh, W.C. Chieh, D.-J. Liaw and L.-J. Li 175

Modification of diamond films by high-energy ion irradiation: "track channelling" and ion charge fluctuation effects
S.A. Fedotov, A.V. Byeli, A.M. Zaitsev, V.S. Varichenko and N.M. Kazyutchits 183

Metallurgical, Protective and Hard Layers

The role of a thin amorphous silicon layer in the fabrication of micro-pored silicon
E.K. Kim, M.-S. Lee, W.C. Choi, H.N. Lee, S.-K. Min and J. Lyou 188

Electronics, Optics and Opto-electronics

The preparation, characterization of amorphous Cu–TCNQ film with a low degree of charge-transfer (DCT) and its electric switching properties
S. Sun, P. Wu and D. Zhu 192

Amorphous r.f.-sputtered $Si_{100-x}Ni_x$ thin films with $0 \leq x \leq 15$ at.%: Structural, optical and electrical properties
A. Belu-Marian, M.D. Serbanescu, R. Manaila, T. Stoica, A. Dragomir, F. Zavaliche, M. Tanase and A. Devenyi 197

Structure-related optical properties of laser-deposited $Ba_xSr_{1-x}TiO_3$ thin films grown on MgO (001) substrates
R. Thielsch, K. Kaemmer, B. Holzapfel and L. Schultz 203

Magnetics and Magneto-optics

Magnetic and magneto-optical properties of (Pt/Co/Pt/Ni) multilayers
G. Srinivas and S.-C. Shin 211

Superconductivity

$MgO/YBa_2Cu_3O_{7-x}$ multilayer thin films grown on (100) $LaAlO_3$ by pulsed laser deposition
M.R. Rao 217

Langmuir–Blodgett, Biological and Related Films

Molecular orientation in liquid crystals on a photochromic polyion complex LB film by FTIR spectroscopy
T. Kawai 225

Thin Film Devices, Sensors and Actuators

Characterization of unintentionally or lightly doped polysilicon films by improved Hall effect measurements
F. Le Bihan, B. Fortin, S. Cauneau, D. Briand and O. Bonnaud 230

Synthesis of multicolor Nb_2O_5 coatings for electrochromic devices
A. Pawlicka, M. Atik and M.A. Aegerter 236

Condensed Matter Film Behaviour

Anodic corrosion of indium tin oxide films induced by the electrochemical oxidation of chlorides
G. Folcher, H. Cachet, M. Froment and J. Bruneaux 242

Logarithmic dependence of the surface anisotropy on the low-angle X-ray diffraction intensity in Co-based multilayers
J.-H. Kim and S.-C. Shin 249

Author Index of Volume 301 253

Subject Index of Volume 301 255

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